

# CE/EMC TEST REPORT

Report No.: BCTC-FY170503283E

### For

### **EXTRA LIGHTING MANUFACTURING LTD.**

	No. No. No.
Product Name:	LED LIGHT
Trademark:	N/A
Model Number:	RH-LPS CL, LP, LED, LG, FL, HB, RH-CL, RH-CLW, RH-GP-TP, RH-S, RH-GK, RH-E, RH-T, RH-D, RH-G, RH-SD
Prepared For:	EXTRA LIGHTING MANUFACTURING LTD.
Address:	NO. 19 Yunpu 1st Road Yunpu Industrial Zone, Guangzhou, 510530 China
Prepared By:	Shenzhen BCTC Testing Co., Ltd.
Address:	BCTC Building & 1-2F, East of B Building, Pengzhou Industrial, Fuyuan 1st Road, Qiaotou Community, Fuyong Street, Bao'an District, Shenzhen, China
Report No.:	BCTC-FY170503283E

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Address

# Shenzhen BCTC Testing Co., Ltd.

Report No.: BCTC-FY170503283E

Applicant : EXTRA LIGHTING MANUFACTURING LTD.

NO. 19 Yunpu 1st Road Yunpu Industrial Zone, Guangzhou,

510530 China

Manufacturer : EXTRA LIGHTING MANUFACTURING LTD.

NO. 19 Yunpu 1st Road Yunpu Industrial Zone, Guangzhou,

510530 China

EUT : LED LIGHT

RH-LPS

Model Number: CL, LP, LED, LG, FL, HB, RH-CL, RH-CLW, RH-GP-TP, RH-S, RH-GK,

RH-E, RH-T, RH-D, RH-G, RH-SD

Trademark: : N/A

Test Date : May 27 – Jun. 02, 2017

Date of Report : Jun. 02, 2017

Test Result: The equipment under test was found to be compliance with the

requirements of the standards applied.

Test Procedure Used:

EMI : EN 55015:2013+A1:2015

EN 61000-3-2:2014, EN 61000-3-3:2013

EMS : EN 61547:2009

EN 61000-4-2:2009, EN 61000-4-3:2006+A1:2008+A2:2010,

EN 61000-4-4:2012, EN 61000-4-5:2014,

EN 61000-4-6:2014, EN 61000-4-8:2010, EN 61000-4-11:2004

Prepared by(Engineer): Kelsey Tan

Reviewer(Supervisor): Jade Yang

Approved(Manager): Carson Zhang

This test report is based on a single evaluation of one sample of above mentioned products. It is not permitted to be duplicated in extracts without written approval of Shenzhen BCTC Testing Co., Ltd.

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### 1. GENERAL INFORMATION

1.1. Description of Device (EUT)

EUT : LED LIGHT

Trademark : N/A

**RH-LPS** 

Model Number : CL, LP, LED, LG, FL, HB, RH-CL, RH-CLW, RH-GP-TP,

RH-S, RH-GK, RH-E, RH-T, RH-D, RH-G, RH-SD

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Model Difference The product is different for model number and outlook color.

Power Supply : Input:AC 220-240V 50/60Hz Max:0.4A

Output:DC27-40V 40W

Note: RH-LPS was selected as the test model and the datas have been recorded in

this report.

1.2. Tested System Details

None.

1.3. Test Uncertainty

**Conducted Emission** 

±2.66dB

Uncertainty

Radiated Emission Uncertainty: ±4.26dB

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# 1.4. Test Facility

Site Description

Name of Firm : Shenzhen BCTC Testing Co., Ltd.

BCTC Building & 1-2F, East of B Building, Pengzhou

Report No.: BCTC-FY170503283E

Site Location : Industrial, Fuyuan 1st Road, Qiaotou Community,

Fuyong Street, Bao'an District, Shenzhen, China

Lab Qualifications : Certificated by Industry Canada

Registration No.: 12655A

Date of registration: January 19, 2015

Certificated by FCC, USA Registration No.: 187086

Date of registration: November 28, 2014

Certificated by CNAS China Registration No.: CNAS L6046

Date of registration: February 3, 2013

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# 2. TEST INSTRUMENT USED

# For Conducted Emission at the mains terminals Test

Conducted Emission Test ( A site )						
Equipment	Manufacturer	Model#	Serial#	Last Cal.	Next Cal.	
843 Shielded Room	ChengYu	843 Room	843	Aug. 25, 2016	Aug. 24, 2017	
EMI Receiver	R&S	ESCI	101421	Aug. 27, 2016	Aug. 26, 2017	
LISN	Schwarzbeck	NSLK8127	8127739	Sep. 07, 2016	Sep. 06, 2017	
Attenuator	R&S	ESH3-Z2	BCTC021E	Aug. 25, 2016	Aug. 24, 2017	
843 Cable 1#	FUJIKURA	843C1#	001	Aug. 25, 2016	Aug. 24, 2017	

For Magnetic Emission Test

Conducted Emission Test ( A site )							
Equipment	Manufacturer	Model#	Serial#	Last Cal.	Next Cal.		
843 Shielded Room	ChengYu	843 Room	843	Aug. 25, 2016	Aug. 24, 2017		
EMI Receiver	R&S	ESCI	101421	Aug. 27, 2016	Aug. 26, 2017		
Three-loop antenna	DAZE	ZN30401	13017	Aug. 25, 2016	Aug. 24, 2017		
Attenuator	R&S	ESH3-Z2	BCTC021E	Aug. 25, 2016	Aug. 24, 2017		
843 Cable 2#	FUJIKURA	843C1#	002	Aug. 25, 2016	Aug. 24, 2017		

# For Radiated Emission Test

	Radiation Emission Test (966 chamber)						
Equipment	Manufacturer	Model#	Serial#	Last Cal.	Next Cal.		
966 chamber	ChengYu	966 Room	966	Aug. 25, 2016	Aug. 24, 2017		
Spectrum Analyzer	Agilent	E4407B	MY45109572	Aug. 27, 2016	Aug. 26, 2017		
Amplifier	Schwarzbeck	BBV9743	9743-119	Aug. 25, 2016	Aug. 24, 2017		
Amplifier	Schwarzbeck	BBV9718	9718-270	Aug. 25, 2016	Aug. 24, 2017		
Log-periodic Antenna	Schwarzbeck	VULB9160	VULB9160-3 369	Sep. 07, 2016	Sep. 06, 2017		
EMI Receiver	R&S	ESCI	101421	Aug. 27, 2016	Aug. 26, 2017		
Horn Antenna	Schwarzbeck	BBHA9120D	9120D-1275	Aug. 25, 2016	Aug. 24, 2017		
966 Cable 1#	CHENGYU	966	004	Aug. 25, 2016	Aug. 24, 2017		
966 Cable 2#	CHENGYU	966	003	Aug. 25, 2016	Aug. 24, 2017		

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# For Harmonic & Flicker Test

For Harmonic / Flicker Test ( A site )							
Equipment	Manufacturer	Model#	Serial#	Last Cal.	Next Cal.		
Harmonic / Flicker Analyzer	KIKUSUI	KHA1000	VA002445	Sep. 07, 2016	Sep. 06, 2017		
AC Power Supply	KIKUSUI	PCR4000M	UK001879	Sep. 07, 2016	Sep. 06, 2017		
Line Impedance network	KIKUSUI	LIN1020JF	UL001611	Sep. 07, 2016	Sep. 06, 2017		

For Electrostatic Discharge Immunity Test

For Electrostatic Discharge Immunity Test ( A site )							
Equipment	Equipment Manufacturer Model# Serial# Last Cal. Next Cal.						
ESD Tester	KIKISUI	KES4201A	UH002321	Aug. 28, 2016	Aug. 27, 2017		

For RF Field Strength Susceptibility Test(SMQ)

1 01 111	To the field offerigit oddeceptionity residence							
	For RF Field Strength Susceptibility Test (SMQ site)							
Equipment	Manufacturer	Model#	Serial#	Last Cal.	Next Cal.			
Signal Generator	HP	8648A	3625U00573	Sep. 26, 2016	Sep. 26, 2017			
Amplifier	A&R	500A100	17034	Sep. 26, 2016	Sep. 26, 2017			
Amplifier	A&R	100W/1000M1	17028	Sep. 26, 2016	Sep. 26, 2017			
Audio Analyzer (20Hz~1GHz)	Panasonic	2023B	202301/428	Sep. 26, 2016	Sep. 26, 2017			
Isotropic Field Probe	A&R	FP2000	16755	Sep. 26, 2016	Sep. 26, 2017			
Antenna	EMCO	3108	9507-2534	Sep. 26, 2016	Sep. 26, 2017			
Log-periodic Antenna	A&R	AT1080	16812	Sep. 26, 2016	Sep. 26, 2017			

For Electrical Fast Transient /Burst Immunity Test

For Electrical Fast Transient/Burst Immunity Test ( A site )						
Equipment	Manufacturer	Model#	Serial#	Last Cal.	Next Cal.	
Burst Tester	Prima	EFT61004AG	PR14054467	Aug. 27, 2016	Aug. 26, 2017	
Coupling Clamp	Prima	EFT61004AG	BCTC009E	Aug. 27, 2016	Aug. 26, 2017	

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For Surge Test

For Surge Test ( A site )						
Equipment	Equipment Manufacturer Model# Serial# Last Cal. Next Cal.					
Surge Tester	Prima	SUG61005BX	PR12045446	Aug. 27, 2016	Aug. 26, 2017	

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For Injected Currents Susceptibility Test

	For Injected Currents Susceptibility Test ( A site )									
Equipment Manufacturer Model# Serial# Last Cal. No										
C/S Test System	SCHLODER	CDG600	126B1281	Aug. 27, 2016	Aug. 26, 2017					
CDN	SCHLODER	CDN-M2+3	A2210320/20 15	Aug. 27, 2016	Aug. 26, 2017					
Injection Clamp	SCHLOBER	EMCL-20	132A1214/20 15	Aug. 27, 2016	Aug. 26, 2017					

For Magnetic Field Immunity Test

For Magnetic Field Immunity Test ( A site )								
Equipment Manufacturer Model# Serial# Last Cal. Next Cal.								
Magnetic field generator	HTEC	HPFMF	15701	Aug. 27, 2016	Aug. 26, 2017			

For Voltage Dips Interruptions Test

	For Voltage Dips Interruptions Test ( A site )								
Equipment Manufacturer Model# Serial# Last Cal. Nex									
	Dips Tester	Prima	DRP61011AG	PR14086284	Aug. 27, 2016	Aug. 26, 2017			

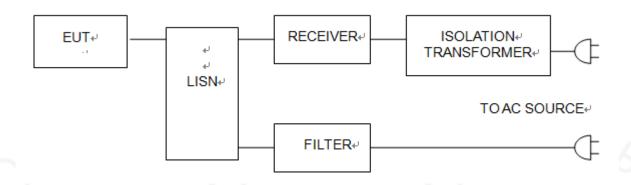
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### 3. CONDUCTED EMISSION AT THE MAINS TERMINALS TEST

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# 3.1.Block Diagram Of Test Setup



#### 3.2. Test Standard

EN 55015:2013+A1:2015

#### 3.3. Power Line Conducted Emission Limit

Frequency	Limits dB(μV)				
MHz	Quasi-peak Level	Average Level			
0.009 ~ 0.05	110	N/A			
0.05 ~ 0.15	90 ~ 80*	N/A			
0.15 ~ 0.50	66 ~ 56*	56 ~ 46*			
0.50 ~ 5.00	56	46			
5.00 ~ 30.00	60	50			

Notes: 1. \*Decreasing linearly with logarithm of frequency.

# 3.4.EUT Configuration on Test

The following equipments are installed on conducted emission test to meet EN55015 requirement and operating in a manner which tends to maximize its emission characteristics in a normal application.

# 3.5. Operating Condition of EUT

- 3.5.1 Setup the EUT and simulators as shown in Section 3.1.
- 3.5.2 Turn on the power of all equipments.
- 3.5.3 Let the EUT work in test modes and test it.

<sup>2.</sup> The lower limit shall apply at the transition frequencies.



#### 3.6. Test Procedure

The EUT is put on the ground and connected to the AC mains through a Artificial Mains Network (AMN). This provided a 50ohm coupling impedance for the tested equipments. Both sides of AC line are checked to find out the maximum conducted emission levels according to the **EN55015** regulations during conducted emission test.

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The bandwidth of the test receiver (R&S Test Receiver ESCI) is set at 10KHz.

The frequency range from 150 KHz to 30 MHz is investigated.

#### 3.7.Test Result

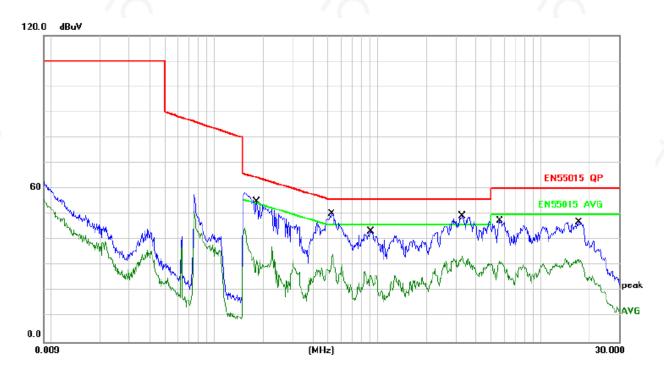
**PASS** 

Please refer to the following page.

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Conducted Emission At The Mains Terminals Test Data									
Temperature: 24.5 °C Relative Humidity: 54%									
Pressure:	1009hPa	Phase :	Lin						
Test Voltage :	AC 230V/50Hz	Test Mode:	ON Mode						

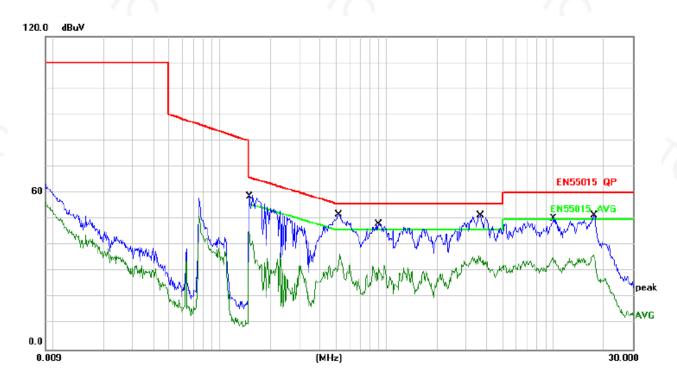


No.	Mk.	Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Over		
		MHz	dBuV	dB	dBuV	dBuV	dB	Detector	Comment
1		0.1819	45.34	9.67	55.01	64.39	-9.38	QP	
2		0.1819	22.57	9.67	32.24	54.39	-22.15	AVG	
3	*	0.5220	40.54	9.68	50.22	56.00	-5.78	QP	
4		0.5220	24.74	9.68	34.42	46.00	-11.58	AVG	
5		0.9060	33.72	9.70	43.42	56.00	-12.58	QP	
6		0.9060	16.68	9.70	26.38	46.00	-19.62	AVG	
7		3.2980	39.51	9.72	49.23	56.00	-6.77	QP	
8		3.2980	23.91	9.72	33.63	46.00	-12.37	AVG	
9		5.7020	37.18	9.76	46.94	60.00	-13.06	QP	
10		5.7020	21.51	9.76	31.27	50.00	-18.73	AVG	
11		17.1100	37.15	9.95	47.10	60.00	-12.90	QP	
12		17.1100	22.49	9.95	32.44	50.00	-17.56	AVG	

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Conducted Emission At The Mains Terminals Test Data									
Temperature: 24.5 ℃ Relative Humidity: 54%									
Pressure:	1009hPa	Phase :	Neutral						
Test Voltage :	AC 230V/50Hz	Test Mode:	ON Mode						



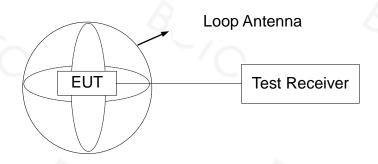
No.	Mk.	Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Over		
		MHz	dBuV	dB	dBuV	dBuV	dB	Detector	Comment
1		0.1527	49.50	9.73	59.23	65.85	-6.62	QP	
2		0.1527	32.13	9.73	41.86	55.85	-13.99	AVG	
3	*	0.5180	42.06	9.68	51.74	56.00	-4.26	QP	
4		0.5180	27.02	9.68	36.70	46.00	-9.30	AVG	
5		0.9020	38.54	9.70	48.24	56.00	-7.76	QP	
6		0.9020	21.57	9.70	31.27	46.00	-14.73	AVG	
7		3.6620	41.58	9.73	51.31	56.00	-4.69	QP	
8		3.6620	25.94	9.73	35.67	46.00	-10.33	AVG	
9		10.0380	40.54	9.84	50.38	60.00	-9.62	QP	
10		10.0380	25.43	9.84	35.27	50.00	-14.73	AVG	
11		17.4500	41.46	9.95	51.41	60.00	-8.59	QP	
12		17.4500	26.63	9.95	36.58	50.00	-13.42	AVG	

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### 4. MAGNETIC EMISSION TEST

# 4.1. Block Diagram Of Test Setup



#### 4.2.Test Standard

EN 55015:2013+A1:2015

#### 4.3. Power Line Conducted Emission Limit

Frequency	Limits dB(μA)
MHz	Quasi-peak Level
0.009 ~ 0.07	88
0.07 ~ 0.15	88 ~ 58*
0.15 ~ 0.50	58 ~ 22*
0.50 ~ 5.00	22

Notes: 1. \*Decreasing linearly with logarithm of frequency.

# 4.4.EUT Configuration on Test

The following equipments are installed on conducted emission test to meet EN55015 requirement and operating in a manner which tends to maximize its emission characteristics in a normal application.

# 4.5. Operating Condition of EUT

- 4.5.1 Setup the EUT and simulators as shown in Section 4.1.
- 4.5.2 Turn on the power of all equipments.
- 4.5.3 Let the EUT work in test modes and test it.

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<sup>2.</sup> The lower limit shall apply at the transition frequencies.



#### 4.6.Test Procedure

The EUT is placed on a wood table in the center of a loop antenna. The induced current in the loop antenna is measured by means of a current probe and the test receiver. Three field components is checked by means of a coax switch.

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The frequency range from 9KHz to 30MHz is investigated. The receiver is measured with the quasi-peak detector. For frequency band 9KHz to 150KHz, the bandwidth of the field strength meter (R&S Test Receiver ESCI) is set at 200Hz. For frequency band 150KHz to 30MHz, the bandwidth is set at 10KHz.

#### 4.7. Test Result

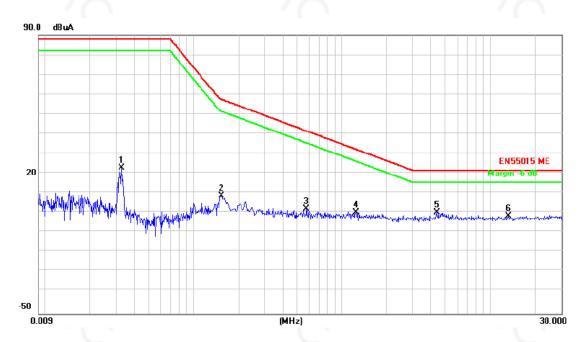
**PASS** 

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Magnetic Emission Test Data								
Temperature: 24.5 ℃ Relative Humidity: 54%								
Pressure:	1009hPa	Ant. Polarity	X					
Test Voltage :	AC 230V/50Hz	Test Mode:	ON Mode					

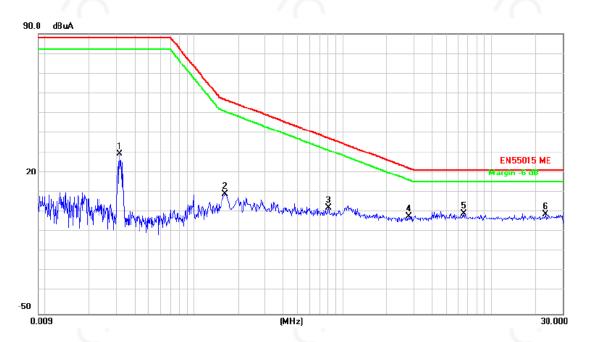


No. Mk.	Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Over		
	MHz	dBuA	dB	dBuA	dBuA	dB	Detector	Comment
1	0.0330	1.12	22.27	23.39	88.00	-64.61	QP	
2	0.1540	-17.77	27.00	9.23	57.68	-48.45	QP	
3	0.5820	-24.33	27.00	2.67	41.71	-39.04	QP	
4	1.2460	-26.09	27.00	0.91	32.56	-31.65	QP	
5 *	4.3540	-26.16	27.00	0.84	22.00	-21.16	QP	
6	13.2740	-27.70	27.00	-0.70	22.00	-22.70	QP	

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Magnetic Emission Test Data								
Temperature: 24.5 ℃ Relative Humidity: 54%								
Pressure:	1009hPa	Ant. Polarity	Υ					
Test Voltage :	AC 230V/50Hz	Test Mode:	ON Mode					



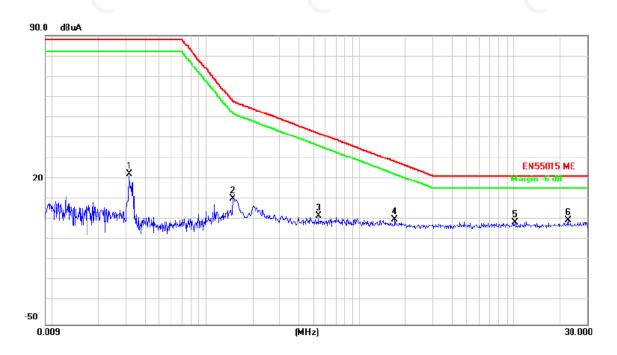
No. Mk.	Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Over		
	MHz	dBuA	dB	dBuA	dBuA	dB	Detector	Comment
1	0.0317	7.41	22.44	29.85	88.00	-58.15	QP	
2	0.1620	-16.96	27.00	10.04	57.08	-47.04	QP	
3	0.8100	-23.99	27.00	3.01	37.73	-34.72	QP	
4	2.8060	-28.05	27.00	-1.05	22.80	-23.85	QP	
5 *	6.5220	-26.80	27.00	0.20	22.00	-21.80	QP	
6	22.9900	-27.29	27.00	-0.29	22.00	-22.29	QP	

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Magnetic Emission Test Data							
Temperature:	<b>24.5</b> ℃	Relative Humidity:	54%				
Pressure:	1009hPa	Ant. Polarity	Z				
Test Voltage :	AC 230V/50Hz	Test Mode:	ON Mode				



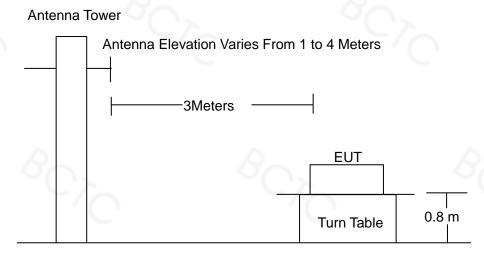
No. Mk.	Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Over		
	MHz	dBuA	dB	dBuA	dBuA	dB	Detector	Comment
1	0.0316	0.45	22.45	22.90	88.00	-65.10	QP	
2	0.1500	-15.87	27.00	11.13	58.00	-46.87	QP	
3	0.5380	-24.29	27.00	2.71	42.65	-39.94	QP	
4	1.6940	-25.95	27.00	1.05	28.87	-27.82	QP	
5	10.2620	-27.53	27.00	-0.53	22.00	-22.53	QP	
6 *	22.5820	-26.57	27.00	0.43	22.00	-21.57	QP	

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### 5. RADIATION EMISSION TEST

# 5.1. Block Diagram of Test Setup



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**Ground Plane** 

### 5.2. Test Standard

EN 55015:2013+A1:2015

#### 5.3. Radiation Limit

Frequency MHz	Distance (Meters)	Field Strengths Limits dB(μV)/m		
30 ~ 230	3	40.0		
230 ~ 300	3	47.0		

#### Remark:

- (1) Emission level  $(dB(\mu V)/m) = 20 \log Emission level (\mu V/m)$
- (2) The smaller limit shall apply at the cross point between two frequency bands.
- (3) Distance refers to the distance in meters between the measuring instrument, antenna and the closed point of any part of the device or system.

# 5.4.EUT Configuration on Test

The EN55015 regulations test method must be used to find the maximum emission during radiated emission test.

The configuration of EUT is the same as used in conducted emission test. Please refer to Section 2.2.



# 5.5. Operating Condition of EUT

Same as conducted emission test, which is listed in Section 2.2 except the test set up replaced as Section 4.1.

Report No.: BCTC-FY170503283E

#### 5.6. Test Procedure

The EUT and its simulators are placed on a turned table that is 0.8 meter above the ground. The turned table can rotate 360 degrees to determine the position of the maximum emission level. The EUT is set 3 meters away from the receiving antenna that is mounted on the antenna tower. The antenna can move up and down between 1 meter and 4 meters to find out the maximum emission level. Broadband antenna (calibrated biconical and log periodical antenna) is used as receiving antenna. Both horizontal and vertical polarization of the antenna is set on test. In order to find the maximum emission levels, the interface cable must be manipulated according to EN55015 on radiated emission test.

The bandwidth setting on the field strength meter (R&S Test Receiver ESCI) is set at 120KHz.

The frequency range from 30MHz to 300MHz is checked.

#### 5.7.Test Result

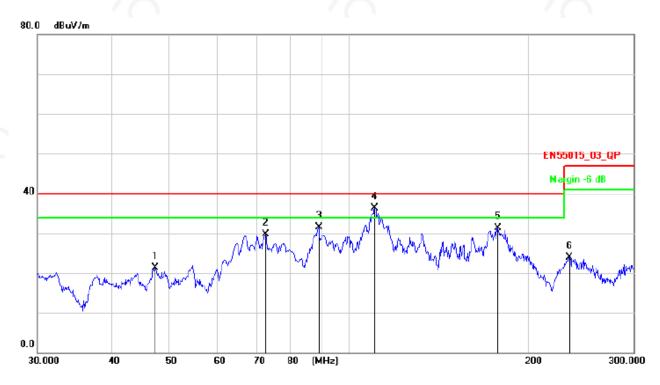
**PASS** 

Please refer to the following page.

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Radiation Emission Test Data							
Temperature:	<b>24.5</b> ℃	Relative Humidity:	54%				
Pressure:	1009hPa	Phase :	Horizontal				
Test Voltage :	AC 230V/50Hz	Test Mode:	ON Mode				



No.	Mk	Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Over		Antenna Height	Table Degree	
		MHz	dBuV	dB	dBuV/m	dB/m	dB	Detector	cm	degree	Comment
1		47.3283	35.98	-14.74	21.24	40.00	-18.76	QP			
2		72.4637	49.62	-19.82	29.80	40.00	-10.20	QP			
3		88.9448	50.02	-18.49	31.53	40.00	-8.47	QP			
4	*	110.4387	52.92	-16.54	36.38	40.00	-3.62	QP			
5		177.4685	49.38	-17.98	31.40	40.00	-8.60	QP			
6		234.4883	38.29	-14.36	23.93	47.00	-23.07	QP			

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Radiation Emission Test Data							
Temperature:	<b>24.5</b> ℃	Relative Humidity:	54%				
Pressure:	1009hPa	Phase :	Vertical				
Test Voltage :	AC 230V/50Hz	Test Mode:	ON Mode				



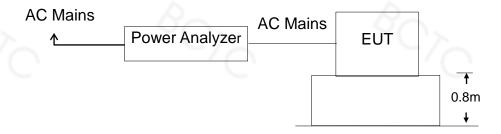
No.	Mk	. Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Over		Antenna Height	Table Degree	
		MHz	dBuV	dB	dBuV/m	dB/m	dB	Detector	cm	degree	Comment
1	*	44.4755	51.39	-14.85	36.54	40.00	-3.46	QP			
2	İ	65.9358	52.62	-17.13	35.49	40.00	-4.51	QP			
3		95.3062	47.08	-17.17	29.91	40.00	-10.09	QP			
4		129.4556	46.20	-19.48	26.72	40.00	-13.28	QP			
5		180.7679	45.00	-17.68	27.32	40.00	-12.68	QP			
6		253.0004	31.94	-13.64	18.30	47.00	-28.70	QP			

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### 6. HARMONIC CURRENT EMISSION TEST

# 6.1. Block Diagram of Test Setup



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#### 6.2. Test Standard

EN 61000-3-2:2014

### 6.3. Operating Condition of EUT

- 6.3.1 Setup the EUT as shown in Section 6.1.
- 6.3.2 Turn on the power of all equipments.
- 6.3.3 Let the EUT work in test mode and test it.

#### 6.4. Test Procedure

The power cord of the EUT is connected to the output of the test system. Turn on the power of the EUT and use the test system to test the harmonic current level.

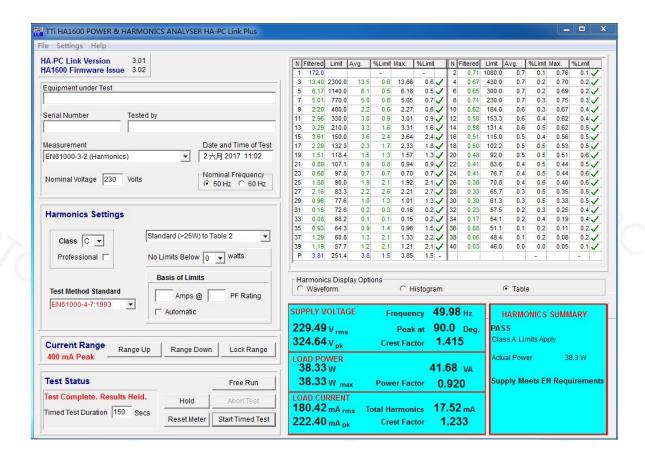
#### 6.5. Test Results

#### **PASS**

Please refer to the following page.

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HA-PC Link Version 3.01 HA1600 Firmware Issue 3.02

Tested by

Basis of Limits

☐ Automatic

Hold

Reset Meter

Start Timed Test

Range Up

Equipment under Test

EN61000-3-2 (Harmonics)

Harmonics Settings

Class C ▼

Professional |

Test Method Standard

EN61000-4-7:1993

Current Range

Test Complete. Results Held.

Timed Test Duration 150 Secs

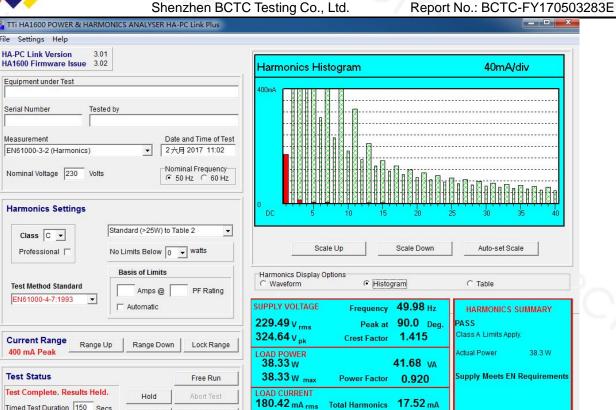
400 mA Peak

Nominal Voltage 230 Volts

Serial Number

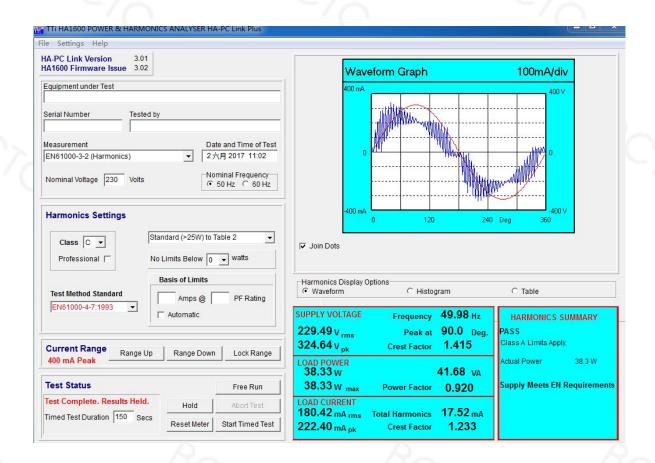
Measurement

Shenzhen BCTC Testing Co., Ltd.



Crest Factor

1.233



222.40 mA pk

**EMC** Report

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0755-33019988

Web: Http://www.bctc-lab.com.cn



### 7. VOLTAGE FLUCTUATIONS & FLICKER TEST

# 7.1. Block Diagram of Test Setup

Same as Section 6.1..

#### 7.2. Test Standard

EN 61000-3-3:2013

# 7.3. Operating Condition of EUT

Same as Section 5.3.. The power cord of the EUT is connected to the output of the test system. Turn on the power of the EUT and use the test system to test the harmonic current level.

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#### Flicker Test Limit

Test items	Limits
Pst	1.0
dc	3.3%
dmax	4.0%
dt	Not exceed 3.3% for
	500ms

#### 7.4. Test Procedure

The power cord of the EUT is connected to the output of the test system. Turn on the power of the EUT and use the test system to test the harmonic current level.

#### 7.5. Test Results

#### **PASS**

Please refer to the following page.

EMC Report

Shenzhen BCTC Testing Co., Ltd.

Flicker Test Data							
Temperature:	24.5 ℃	Relative Humidity:	54%				
Pressure:	1009hPa	Phase :	Vertical				
Test Voltage :	AC 230V/50Hz	Test Mode:	ON				

Report No.: BCTC-FY170503283E

Voltage Fluctuation	Limit	Value
Relative Voltage Change Characteristic Tmax (dc>3%)	500 ms	0 ms
	4%	0.00
Maximum Relative Voltage Change dmax	6%	18
	7%	/
Relative Steady-state Voltage Change dc	3.3%	0.00

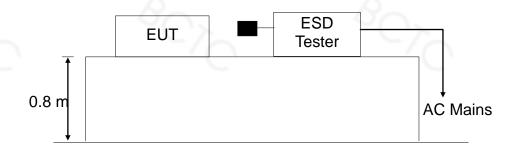
Flicker	Limit	Value
Short-term Flicker Indicator Pst	1.0	0.064
Long-term Flicker Indicator Plt	0.65	/

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# 8. ELECTROSTATIC DISCHARGE IMMUNITY TEST

# 8.1.Block Diagram of Test Setup



Report No.: BCTC-FY170503283E

### 8.2. Test Standard

EN 61547:2009, EN 61000-4-2:2009

Severity Level: 3 / Air Discharge:±8KV Level: 2 / Contact Discharge:±4KV

# 8.3. Severity Levels and Performance Criterion

8.3.1 Severity level

Level	Test Voltage Contact Discharge (KV)	Test Voltage Air Discharge (KV)
1.	±2	±2
2.	±4	±4
3.	±6	±8
4.	±8	±15
Х	Special	Special



#### 8.3.2 Performance criterion: B

A. The equipment shall continue to operate as intended without operator intervention. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer when the equipment is used as intended. The performance level may be replaced by a permissible loss of performance. If the minimum performance level or the permissible performance loss is not specified by the manufacturer, then either of these may be derived from the product description and documentation, and by what the user may reasonably expect from the equipment if used as intended.

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B. After the test, the equipment shall continue to operate as intended without operator intervention. No degradation of performance or loss of function is allowed, after the application of the phenomena below a performance level specified by the manufacturer, when the equipment is used as intended. The performance level may be replaces by a permissible loss of performance.

During the test, degradation of performance is allowed. However, no change of operating state or stored data is allowed to persist after the test.

If the minimum performance level (or the permissible performance loss) is not specified by the manufacturer, then either of these may be derived from the product description and documentation, and by what the user may reasonably except from the equipment if used as intended.

C. Loss of function is allowed, provided the function is self-recoverable, or can be restored by the operation of the controls by the user in accordance with the manufacturer's instructions. Functions, and/or information stored in non-volatile memory, or protected by a battery backup, shall not be lost.

# 8.4.EUT Configuration

The following equipments are installed on Electrostatic Discharge Immunity test to meet EN 61547:2009, EN 61000-4-2:2009, requirement and operating in a manner which tends to maximize its emission characteristics in a normal application. The configuration of EUT is the same as used in conducted emission test.

Please refer to Section 2.4.



### 8.5. Operating Condition of EUT

Same as conducted emission measurement, which is listed in Section 3.5 except the test setup replaced by Section 7.1.2.

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#### 8.6. Test Procedure

#### 8.6.1 Air Discharge:

This test is done on a non-conductive surface. The round discharge tip of the discharge electrode shall be approached as fast as possible to touch the EUT. After each discharge, the discharge electrode shall be removed from the EUT. The generator is then re-triggered for a new single discharge and repeated 10 times for each pre-selected test point. This procedure shall be repeated until all the air discharge completed.

#### 8.6.2 Contact Discharge:

All the procedure shall be same as Section 7.6.1. Except that the tip of the discharge electrode shall touch the EUT before the discharge switch is operated.

#### 8.6.3 Indirect discharge for horizontal coupling plane

At least 10 single discharges (in the most sensitive polarity) shall be applied at the front edge of each HCP opposite the center point of each unit (if applicable) of the EUT and 0.1m from the front of the EUT. The long axis of the discharge electrode shall be in the plane of the HCP and perpendicular to its front edge during the discharge.

#### 8.6.4 Indirect discharge for vertical coupling plane

At least 10 single discharges (in the most sensitive polarity) shall be applied to the center of one vertical edge of the coupling plane. The coupling plane, of dimensions 0.5m X 0.5m, is placed parallel to, and positioned at a distance of 0.1m from the EUT. Discharges shall be applied to the coupling plane, with this plane in sufficient different positions that the four faces of the EUT are complete illuminated.

#### 8.7.Test Results

#### **PASS**

Please refer to the following page.



Shenzhen BCTC Testing Co., Ltd.

ESD Test Data			
Temperature:	24.5℃	Humidity:	53%
Power Supply :	AC 230V/50Hz	Test Mode:	On

Report No.: BCTC-FY170503283E

Air Discharge: ± 8KV

Contact Discharge: ± 4KV

		/ / \		/ \
Test Points	Air Discharge	Contact Discharge	Performance Criterion	Result
Enclosure	±2,4,8KV	N/A	В	PASS
Slit	±2,4,8KV	N/A	В	PASS
Metal Part	N/A	±2,4 KV	В	PASS
VCP	N/A	±2,4 KV	В	PASS
HCP	N/A	±2,4 KV	В	PASS
00	000		0/\	

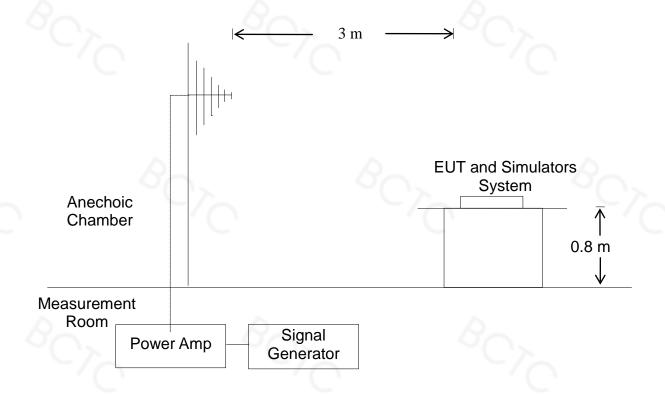
Note: N/A

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# 9. RF FIELD STRENGTH SUSCEPTIBILITY TEST

# 9.1.Block Diagram of Test Setup



# 9.2.Test Standard

EN 61547:2009, EN 61000-4-3: 2006+A1:2008+A2:2010 Severity Level 2, 3V / m

# 9.3. Severity Levels and Performance Criterion

### 9.3.1. Severity level

Level	Field Strength V/m	
1.	1	
2.	3	
3.	10	
X.	Special	

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#### 9.3.2. Performance criterion: A

A. The equipment shall continue to operate as intended without operator intervention. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer when the equipment is used as intended. The performance level may be replaced by a permissible loss of performance. If the minimum performance level or the permissible performance loss is not specified by the manufacturer, then either of these may be derived from the product description and documentation, and by what the user may reasonably expect from the equipment if used as intended.

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B. After the test, the equipment shall continue to operate as intended without operator intervention. No degradation of performance or loss of function is allowed, after the application of the phenomena below a performance level specified by the manufacturer, when the equipment is used as intended. The performance level may be replaces by a permissible loss of performance.

During the test, degradation of performance is allowed. However, no change of operating state or stored data is allowed to persist after the test.

If the minimum performance level (or the permissible performance loss) is not specified by the manufacturer, then either of these may be derived from the product description and documentation, and by what the user may reasonably except from the equipment if used as intended.

C Loss of function is allowed, provided the function is self-recoverable, or can be restored by the operation of the controls by the user in accordance with the manufacturer's instructions. Functions, and/or information stored in non-volatile memory, or protected by a battery backup, shall not be lost.

# 9.4. EUT Configuration on Test

The following equipments are installed on Electrical Fast Transient/Burst Immunity test to meet EN 61547:2009, EN 61000-4-4:2012, requirement and operating in a manner which tends to maximize its emission characteristics in a normal application. The configuration of EUT is the same as used in conducted emission test.

Please refer to Section 3.4.

# 9.5. Operating Condition of EUT

Same as conducted emission measurement, which is listed in Section 2.5 except the test setup replaced by Section 8.1.



### 9.6. Test Procedure

The EUT and its simulators are placed on a turn table which is 0.8 meter above ground. EUT is set 3 meter away from the transmitting antenna which is mounted on an antenna tower. Both horizontal and vertical polarization of the antenna are set on test. Each of the four sides of EUT must be faced this transmitting antenna and measured individually.

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All the scanning conditions are as follows:

Condition of Test		Remarks	
1.	Fielded Strength	3 V/m (Severity Level 2)	
2.	Radiated Signal	Modulated	
3.	Scanning Frequency	80 – 1000 MHz	
4.	Dwell time of radiated	0.0015 decade/s	
5.	Waiting Time	1 Sec.	

### 9.7. Test Results

### **PASS**

Please refer to the following page.

	R/S Tes	st Data	-C/2
Temperature : 25°C	,	Humidity: 53%	
Field Strength: 3 V/n	า	Criterion: A	
Power Supply: AC 23	30V/50Hz	Frequency Range	: 80 MHz to 1000 MHz
Modulation:	☑ AM □ Pulse	□none 1 K	Hz 80%
Test Mode: On	80.	80.	
/_	Frequency Range:	80-1000MHz	
Steps	1 %		C,
	Horizontal	Vertical	Result
Front	А	А	Pass
Right	A	A	Pass
Rear	Α	А	Pass
Left	Α	Α	Pass
Note: N/A		-/0	-/0

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# 10. ELECTRICAL FAST TRANSIENT/BURST IMMUNITY TEST

Report No.: BCTC-FY170503283E

### 10.1. Block Diagram of EUT Test Setup



#### 10.2. Test Standard

EN 61547:2009, EN 61000-4-4:2012

### 10.3. Severity Levels and Performance Criterion

Severity Level 2 at 1KV, Pulse Rise time & Duration: 5 nS / 50 nS Severity Level:

coroni, zoron			
Open Circuit Output Test Voltage ±10%			
On power ports	On I/O(Input/Output)		
	Signal data and control ports		
0.5KV	0.25KV		
1KV	0.5KV		
2KV	1KV		
4KV	2KV		
Special	Special		
	On power ports  0.5KV  1KV  2KV  4KV		

#### Performance criterion: B

- A. The equipment shall continue to operate as intended without operator intervention. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer when the equipment is used as intended. The performance level may be replaced by a permissible loss of performance. If the minimum performance level or the permissible performance loss is not specified by the manufacturer, then either of these may be derived from the product description and documentation, and by what the user may reasonably expect from the equipment if used as intended.
- B. After the test, the equipment shall continue to operate as intended without operator intervention. No degradation of performance or loss of function is allowed, after the application of the phenomena below a performance level specified by the manufacturer, when the equipment is used as intended. The performance level may be replaces by a permissible loss of performance.

During the test, degradation of performance is allowed. However, no change of operating state or stored data is allowed to persist after the test.



If the minimum performance level (or the permissible performance loss) is not specified by the manufacturer, then either of these may be derived from the product description and documentation, and by what the user may reasonably except from the equipment if used as intended.

C. Loss of function is allowed, provided the function is self-recoverable, or can be restored by the operation of the controls by the user in accordance with the manufacturer's instructions. Functions, and/or information stored in non-volatile memory, or protected by a battery backup, shall not be lost.

### 10.4. EUT Configuration on Test

The following equipments are installed on Electrical Fast Transient/Burst Immunity test to meet EN 61547:2009, EN 61000-4-4:2012, requirement and operating in a manner which tends to maximize its emission characteristics in a normal application. The configuration of EUT is the same as used in conducted emission test.

Please refer to Section 3.4.

# 10.5. Operating Condition of EUT

Same as conducted emission measurement, which is listed in Section 2.6 except the test setup replaced by Section 9.1.

#### 10.6. Test Procedure

EUT shall be placed 0.8m high above the ground reference plane which is a min.1m\*1m metallic sheet with 0.65mm minimum thickness. This reference ground plane shall project beyond the EUT by at least 0.1m on all sides and the minimum distance between EUT and all other conductive structure, except the ground plane beneath the EUT, shall be more than 0.5m

#### 9.6.1. For input and output AC power ports:

The EUT is connected to the power mains by using a coupling device which couples the EFT interference signal to AC power lines. Both polarities of the test voltage should be applied during compliance test and the duration of the test is 2 minutes.

#### 10.7. Test Results

PASS

Please refer to the following page.

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±0.5kV

		EFT T	est Data					
Temperature:	24.5℃ Humidity:		53	53%				
Power Supply :	AC 230V/50Hz	Test Mode:		Or	On			
00		00	1		00	٦.		
Test Voltage				Performance Result				
Coupling Line	±0.5kV		±1kV		Criterion			
L	±0.5kV		±1kV		В	PASS		
N	±0.5kV		±1kV	9,	В	PASS		
L-N	±0.5kV	)	±1kV		В	PASS		
PE	±0.5kV		±1kV		В	N/A		
L-PE	±0.5kV	_	±1kV		В	N/A		
N-PE	±0.5kV	0	±1kV		В	N/A		

±1kV

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В

N/A

Note: N/A

L-N-PE

DC Line

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## 11. SURGE TEST

# 11.1. Block Diagram of EUT Test Setup



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### 11.2. Test Standard

EN 61547:2009, EN61000-4-5:2014

# 11.3. Severity Levels and Performance Criterion

Severity Level: Line to Line, Level 2 at 1KV; Severity Level: Line to Earth, Level 3 at 2KV.

Severity Level	Open-Circuit Test Voltage (KV)
1.	0.5
2.	1.0
3.	2.0
4.	4.0
X.	Special

#### Performance criterion: B

- A. The equipment shall continue to operate as intended without operator intervention. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer when the equipment is used as intended. The performance level may be replaced by a permissible loss of performance. If the minimum performance level or the permissible performance loss is not specified by the manufacturer, then either of these may be derived from the product description and documentation, and by what the user may reasonably expect from the equipment if used as intended.
- B. After the test, the equipment shall continue to operate as intended without operator intervention. No degradation of performance or loss of function is allowed, after the application of the phenomena below a performance level specified by the manufacturer, when the equipment is used as intended. The performance level may be replaces by a permissible loss of performance.

During the test, degradation of performance is allowed. However, no change of operating state or stored data is allowed to persist after the test.



If the minimum performance level (or the permissible performance loss) is not specified by the manufacturer, then either of these may be derived from the product description and documentation, and by what the user may reasonably except from the equipment if used as intended.

C. Loss of function is allowed, provided the function is self-recoverable, or can be restored by the operation of the controls by the user in accordance with the manufacturer's instructions. Functions, and/or information stored in non-volatile memory, or protected by a battery backup, shall not be lost.

## 11.4. EUT Configuration on Test

The following equipments are installed on Electrical Fast Transient/Burst Immunity test to meet EN 61547:2009, EN61000-4-5:2014, requirement and operating in a manner which tends to maximize its emission characteristics in a normal application

The configuration of EUT is the same as used in conducted emission test. Please refer to Section 3.4.

# 11.5. Operating Condition of EUT

Same as conducted emission measurement, which is listed in Section 2.7 except the test setup replaced by Section 10.1.

### 11.6. Test Procedure

- 1) Set up the EUT and test generator as shown on section 10.1
- 2) For line to line coupling mode, provide a 1KV 1.2/50us voltage surge (at open-circuit condition) and 8/20us current surge to EUT selected points.
- 3) At least 5 positive and 5 negative (polarity) tests with a maximum 1/min repetition rate are conducted during test.
- 4) Different phase angles are done individually.
- 5) Repeat procedure 2) to 4) except the open-circuit test voltage change from 1KV to 2KV for line to earth coupling mode test.
- Record the EUT operating situation during compliance test and decide the EUT immunity criterion for above each test.

### 11.7. Test Result

**PASS** 

Please refer to the following page.

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Surge Test Data Temperature: 24.5℃ Humidity: 53% Power Supply: Test Mode: AC 230V/50Hz On Pulse Voltage Performance Location **Polarity** Phase Angle No of Pulse Result (KV) Criterion 90 5 **Pass** 90 5 1 N/A L-N 270 5 1 N/A 270 5 1 **Pass** 90 5 2 N/A + 90 5 2 N/A L-PE В 270 5 2 N/A + 5 270 2 N/A 5 2 N/A 90 + 5 2 N/A 90 N-PE 2 270 5 N/A + 270 5 2 N/A Note: N/A

Shenzhen BCTC Testing Co., Ltd.

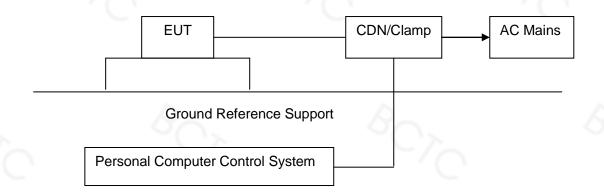
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# 12. INJECTED CURRENTS SUSCEPTIBILITY TEST

# 12.1. Block Diagram of EUT Test Setup



## 12.2. Test Standard

EN 61547:2009, EN61000-4-6:2014

# 12.3. Severity Levels and Performance Criterion

Severity Level 2: 3V( rms ), 150KHz  $\sim$  80MHz Severity Level:

Level	Field Strength V
1.	1
2.	3
3.	10
X.	Special

### **Performance criterion: A**

A. The equipment shall continue to operate as intended without operator intervention. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer when the equipment is used as intended. The performance level may be replaced by a permissible loss of performance. If the minimum performance level or the permissible performance loss is not specified by the manufacturer, then either of these may be derived from the product description and documentation, and by what the user may reasonably expect from the equipment if used as intended.



B. After the test, the equipment shall continue to operate as intended without operator intervention. No degradation of performance or loss of function is allowed, after the application of the phenomena below a performance level specified by the manufacturer, when the equipment is used as intended. The performance level may be replaces by a permissible loss of performance.

During the test, degradation of performance is allowed. However, no change of operating state or stored data is allowed to persist after the test.

If the minimum performance level (or the permissible performance loss) is not specified by the manufacturer, then either of these may be derived from the product description and documentation, and by what the user may reasonably except from the equipment if used as intended.

C. Loss of function is allowed, provided the function is self-recoverable, or can be restored by the operation of the controls by the user in accordance with the manufacturer's instructions. Functions, and/or information stored in non-volatile memory, or protected by a battery backup, shall not be lost.

# 12.4. EUT Configuration on Test

The configuration of EUT is the same as used in conducted emission test. Please refer to Section 2.8.

# 12.5. Operating Condition of EUT

Same as conducted emission test, which is listed in Section 2.8 except the test set up replaced as Section 11.1.

#### 12.6. Test Procedure

- 1) Set up the EUT, CDN and test generator as shown on section 11.1
- 2) Let EUT work in test mode and measure.
- 3) The EUT and supporting equipments are placed on an insulating support 0.1m high above a ground reference plane. CDN (coupling and decoupling device) is placed on the ground plane at above 0.1-0.3m from EUT. Cables between CDN and EUT are as short as possible, and their height above the ground reference plane shall be between 30 and 50 mm (where possible).
- 4) The disturbance signal described below is injected to EUT through CDN.
- 5) The EUT operates within its operational mode(s) under intended climatic conditions after power on.



6) The frequency range is swept from 150KHz to 80MHz using 3V signal level, and with the disturbance signal 80% amplitude modulated with a 1KHz sine wave

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- 7) The rate of sweep shall not exceed 1.5×10<sup>-3</sup> decades/s. Where the frequency is swept incrementally, the step size shall not exceed 1% of the start and thereafter 1% of the preceding frequency value.
- 8) Recording the EUT operating situation during compliance test and decide the EUT immunity criterion for above each test.

## 12.7. Test Result

## PASS

Please refer to the following page.

			CS Test Data				
Tempera	ature:	24	4.5℃	Humid	ity:	5	3%
Power Supply :		AC 230V/50Hz		Test Mode:		On	
Frequency Range(MHz)	Injected Position	Strength	Modulation Signal	Freq. Step		mance erion	Result
150KHz $\sim$ 80MHz	AC Line	3V(rms), Unmodulated	AM 80%, 1kHz sine wave	1%		A	Pass
150KHz $\sim$ 80MHz	DC Line	3V(rms), Unmodulated	AM 80%, 1kHz sine wave	1%		/	

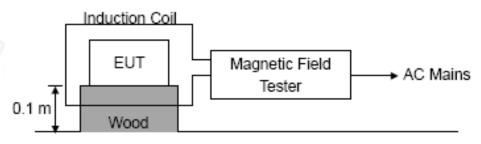
Note: N/A

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## 13. MAGNETIC FIELD IMMUNITY TEST

# 13.1. Block Diagram of Test Setup



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Ground Reference Support

## 13.2. Test Standard

EN 61547:2009, EN61000-4-8:2010 Severity Level 1 at 1A/m

## 13.3. Severity Levels and Performance Criterion

## 13.3.1 Severity level

Level	Magnetic Field Strength A/m
1.	<b>1</b> (C)
2.	3
3.	10
4.	30
5.	100
X.	Special

#### 13.3.2 Performance criterion: B

A. The equipment shall continue to operate as intended without operator intervention. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer when the equipment is used as intended. The performance level may be replaced by a permissible loss of performance. If the minimum performance level or the permissible performance loss is not specified by the manufacturer, then either of these may be derived from the product description and documentation, and by what the user may reasonably expect from the equipment if used as intended.



B. After the test, the equipment shall continue to operate as intended without operator intervention. No degradation of performance or loss of function is allowed, after the application of the phenomena below a performance level specified by the manufacturer, when the equipment is used as intended. The performance level may be replaces by a permissible loss of performance.

During the test, degradation of performance is allowed. However, no change of operating state or stored data is allowed to persist after the test.

If the minimum performance level (or the permissible performance loss) is not specified by the manufacturer, then either of these may be derived from the product description and documentation, and by what the user may reasonably except from the equipment if used as intended.

C. Loss of function is allowed, provided the function is self-recoverable, or can be restored by the operation of the controls by the user in accordance with the manufacturer's instructions. Functions, and/or information stored in non-volatile memory, or protected by a battery backup, shall not be lost.

## 13.4. EUT Configuration on Test

The configuration of EUT is listed in Section 2.9.

# 13.5. Operating Condition of EUT

Same as conducted emission test, which is listed in Section 2.9 except the test set up replaced as Section 12.1.

#### 13.6. Test Procedure

The EUT shall be subjected to the test magnetic field by using the induction coil of standard dimensions (1m\*1m) and shown in Section 10.1. The induction coil shall then be rotated by 90° in order to expose the EUT to the test field with different orientations.

## 13.7. Test Results

### **PASS**

Please refer to the following page.



Shenzhen BCTC Testing Co., Ltd.

	M	S Test Data			
Temperature:	24.5	5°C	Humidit	y:	53%
Power Supply :	AC 230\	AC 230V/50Hz Test Mode:		le:	On
Environmental Phenomena	Test specification	Units	Coil Orientation	Performan ce Criterion	Result
			X	А	PASS
Magnetic Field	3	A/m	Y	А	PASS
	90.	4	Z	А	PASS

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Note: N/A

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## 14. VOLTAGE DIPS AND INTERRUPTIONS TEST

# 14.1. Block Diagram of EUT Test Setup



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## 14.2. Test Standard

EN 61547:2009, EN61000-4-11:2004

# 14.3. Severity Levels and Performance Criterion

Severity Level:

Input and Output AC Power Ports.

☑ Voltage Dips.

✓ Voltage Interruptions.

Environmental	Test Specification	Units	Performance
Phenomena	~( )>	~(	Criterion
	70	% Reduction	)
Voltage Dips	10	period	C
	0	% Reduction	D
	0.5	period	В

## Performance criterion: C, B

- A. The equipment shall continue to operate as intended without operator intervention. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer when the equipment is used as intended. The performance level may be replaced by a permissible loss of performance. If the minimum performance level or the permissible performance loss is not specified by the manufacturer, then either of these may be derived from the product description and documentation, and by what the user may reasonably expect from the equipment if used as intended.
- B. After the test, the equipment shall continue to operate as intended without operator intervention. No degradation of performance or loss of function is allowed, after the application of the phenomena below a performance level specified by the manufacturer, when the equipment is used as intended. The performance level may be replaces by a permissible loss of performance.



During the test, degradation of performance is allowed. However, no change of operating state or stored data is allowed to persist after the test.

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If the minimum performance level (or the permissible performance loss) is not specified by the manufacturer, then either of these may be derived from the product description and documentation, and by what the user may reasonably except from the equipment if used as intended.

C. Loss of function is allowed, provided the function is self-recoverable, or can be restored by the operation of the controls by the user in accordance with the manufacturer's instructions. Functions, and/or information stored in non-volatile memory, or protected by a battery backup, shall not be lost.

# 14.4. EUT Configuration on Test

The configuration of EUT is the same as used in conducted emission test. Please refer to Section 2.10.

# 14.5. Operating Condition of EUT

Same as conducted emission test, which is listed in Section 2.10 except the test set up replaced as Section 13.1.

## 14.6. Test Procedure

- 1) Set up the EUT and test generator as shown on section 13.1
- 2) The interruption is introduced at selected phase angles with specified duration. There is a 3mins minimum interval between each test event.
- 3) After each test a full functional check is performed before the next test.
- 4) Repeat procedures 2 & 3 for voltage dips, only the level and duration is changed.
- 5) Record any degradation of performance.

## 14.7. Test Result

**PASS** 

Please refer to the following page.



DIPS Test Data						
Temperature:	24.5°C	Humidity:	53%			
Power Supply :	AC 230V/50Hz	Test Mode:	On			
Environmental Phenomena	Test Specification	Units	Performance Criterion			
Voltage Dips	70 10	% Reduction period	С			
	0 0.5	% Reduction period	В			

Shenzhen BCTC Testing Co., Ltd.

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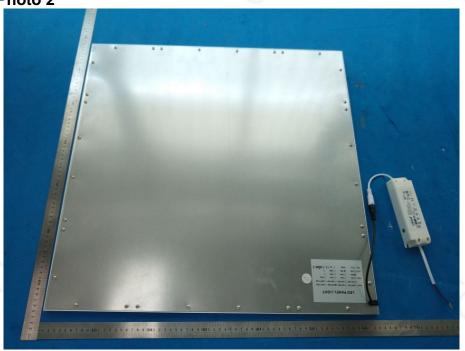


# 15. EUT PHOTOGRAPHS

# **EUT Photo 1**



# **EUT Photo 2**



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# **EUT Photo 3**





# **16. EUT TEST PHOTOGRAPHS**

CE

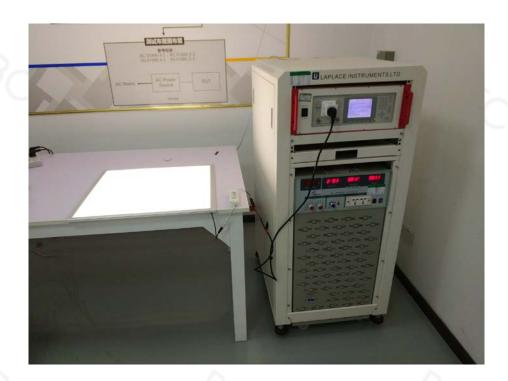


RE





HF

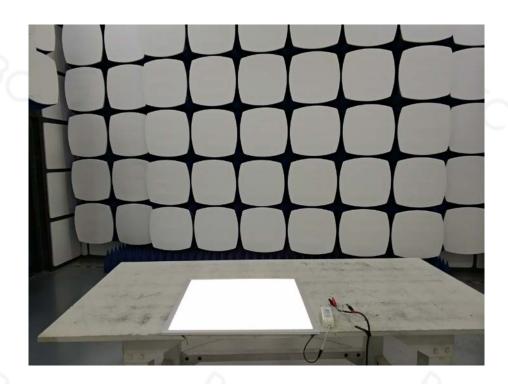


ESD

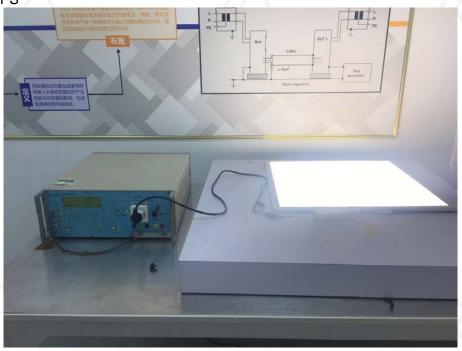




RS



# Surge&EFT&DIPS



CS



**\*\*\*\*** END OF REPORT **\*\*\***